


<b>Search Notes</b>  	<b>Application/Control No.</b>  10594852	<b>Applicant(s)/Patent Under Reexamination</b>  WEI ET AL.
	<b>Examiner</b>  RICHARD BOWEN	<b>Art Unit</b>  2156

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Performed EAST search. Performed inventor search; Performed key word search using terms and plurals of "data" "database" "mining" "partition" "frequent" "pattern" "fp" "growth" "prune" "heuristic"; performed keyword + classification search using classes 705 and 707 and subclasses 707/776 and 707/999.003; performed forward and backward citation searches of most pertinent references.	6/16/10 - 7/9/10	RLB
Performed PLUS search	6/29/10	RLB
Performed Google Scholar search	7/7/10	RLB
Performed IEEE Inspec search	7/1/10	RLB
Performed updated search using EAST and GoogleScholar - see EAST search notes	11/9/2010, 11/12/2010, 11/29/2010	RB
Performed updated search using EAST and GoogleScholar - see EAST search notes	4/21/2011, 4/28/2011, 5/10/2011, 5/17/2011	RB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/R. B./ Examiner.Art Unit 2157	
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